





# NFC TEST REPORT

No.122Z70343-IOT07

for

**SAMSUNG Electronics Co., Ltd.** 

Multi-band GSM/WCDMA/LTE/5GNR Phone with Bluetooth, WLAN

Model Name: SM-A146P/DSN,SM-A146P/N

FCC ID: ZCASMA146PN

with

**Hardware Version: REV1.0** 

Software Version: A146P.001

Issued Date: 2022-11-14

#### Note:

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The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S.Government.

#### **Test Laboratory:**

## CTTL-Telecommunication Technology Labs, CAICT

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# **REPORT HISTORY**

Report Number	Revision	Description	Issue Date
I22Z70343-IOT07	Rev.0	1 <sup>st</sup> edition	2022-11-14

Note: the latest revision of the test report supersedes all previous version.





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## 1. Test Laboratory

## 1.1. Introduction & Accreditation

**Telecommunication Technology Labs, CAICT** is an ISO/IEC 17025:2017 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (ISED#: 24849). The detail accreditation scope can be found on NVLAP website.

## 1.2. Testing Location

Location 1: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China 100191





## 1.3. <u>Testing Environment</u>

Normal Temperature: 15-35°C

Extreme Temperature: -20/+50°C

Normal Relative Humidity: 20-75%

Normal Air Pressure 86Kpa-106Kpa

## 1.4. Project data

Testing Start Date: 2022-09-21
Testing End Date: 2022-10-12

## 1.5. Signature

苗青华

Miao Qinghua

(Prepared this test report)

Zhou Bin

(Reviewed this test report)

Pang Shuai

(Approved this test report)





## 2. Client Information

## 2.1. Applicant Information

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Contact: Jenni Chun

Telephone: +1-201-937-4203

Email: j1.chun@samsung.com

## 2.2. Manufacturer Information

Company Name: Samsung Electronics Co., Ltd.

Samsung R5, Maetan dong 129, Samsung ro

Youngtong gu, Suwon city 443 742, Korea

Contact: Sunghoon Cho
Telephone: +82-10-2722-4159

Email: ggobi.cho@samsung.com





# 3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

## 3.1. About EUT

Description Multi-band GSM/WCDMA/LTE/5GNR Phone with Bluetooth,

**WLAN** 

Model Name SM-A146P/DSN,SM-A146P/N

FCC ID ZCASMA146PN
GSM Frequency bands 850/900/1800/1900
UMTS Frequency bands FDD I/II/IV/V/VIII

E-UTRA Frequency bands FDD 1/2/3/4/5/7/8/12/17/20/26/28/66

TDD 38/40/41

5G NR Frequency bands NSA n1/n3/n5/n7/n8/n20/n28/n38/n40/n41/n77

SA n1/n3/n5/n7/n8/n20/n28/n38/n40/n41/n77

Operating temperature -10/+55°C
Extreme low voltage 3.5 V
Normal voltage 3.85 V
Extreme high voltage 4.4 V

Note: The SM-A146P/DSN is the parent product of the SM-A146P/N. The only difference between the SM-A146P/DSN and the SM-A146P/N is hardware information, the SM-A146P/DSN is dual card, the SM-A146P/N is single card. The model name used in the test is the SM-A146P/DSN.

## 3.2. Internal Identification of EUT

EUT ID*	SN or IMEI	<b>HW Version</b>	SW Version
UT26a	2270343UT26a	REV1.0	A146P.001
UT23a	2270343UT23a	REV1.0	A146P.001

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

## 3.3. Internal Identification of AE

AE ID*	Description	SN	Remarks
AE1	Adapter	/	1
AE2	USB Cable1	1	1
AE3	USB Cable2	/	1
AE4	USB Cable3	1	1
AE5	USB Cable4	1	1
AE6	Headset	1	1
AE7	Battery1	1	1
AE8	Battery2	1	1
AE1			

Model EP-T1510

Manufacturer HAEM Co.,Ltd





Length of cable /

AE2

Model EP-DT725BWE Manufacturer RFTECH Co., Ltd..

Length of cable /

AE3

Model EP-DN980BWZ
Manufacturer RFTECH Co., Ltd.

Length of cable /

AE4

Model EP-DT725BWE

Manufacturer CRESYN HANOI Co., Ltd

Length of cable /

AE5

Model EP-DN980BWE

Manufacturer Guangxi Broad Telecommunication Co.,Ltd.

Length of cable /

AE6

Model EHS61ASFWE

Manufacturer Shenzhen Grandsound Electronics Co.,Ltd

Length of cable /

AE7

Model WT-S-W1

Type Secondary Li-ion Polymer Battery
Manufacturer SCUD (Fujian) Electronics CO.,LTD

AE8

Model SCUD-WT-W1

Type Secondary Li-ion Polymer Battery
Manufacturer SCUD (Fujian) Electronics CO.,LTD

## 3.4. EUT Set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.NFC01	UT23a + AE1 + AE2 + AE7/AE8 + NFC Card	Charge
Set.NFC02	UT23a + AE7/AE8+ NFC card	NFC
Set.NFC03	UT26a	

The Transmit State of NFC: the NFC function is on. The EUT will transmit the NFC data and command continuously during the test.

The Transmit state without modulation: The EUT will transmit the CW signal at the operating frequency.

<sup>\*</sup>AE ID: is used to identify the ancillary equipment in the lab internally.





## 4. Reference Documents

## 4.1. <u>Documents supplied by applicant</u>

EUT parameters, referring to Annex A for detailed information, are supplied by the client or manufacturer, which are the bases of testing.

## 4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
CFR 47 Part 2	Part 2 — Frequency Allocations and Radio Treaty Matters;	2019
	General Rules and Regulations.	
CFR 47 Part 15	Part 15 — Radio Frequency Devices.	2019
	Subpart C — Intentional Radiators.	
	§ 15.35 Measurement detector functions and bandwidths.	
	§ 15.207 Conducted limits.	
	§ 15.209 Radiated emission limits, general requirements.	
	§ 15.215 Additional provisions to the general radiated	
	emission limitations.	
	§ 15.225 Operation within the band 13.110–14.010 MHz.	
ANSI C63.10	American National Standard of Procedures for Compliance	2013
	Testing of Unlicensed Wireless Devices	





## 5. Test Results

## 5.1. Summary of Test Results

No	Test Cases	Clause in Regulation	Section in This Report	Verdict	
1	Electric Field Strength of	CFR 47 § 15.225(a)		P(Set. NFC02)	
'	Fundamental Emissions	01 1 47 g 15.225(a)	B.1	1 (Oct. 141 OO2)	
2	Electric Field Strength of	CFR 47 § 15.225(b)	D. I	P(Set. NFC02)	
	Outside the Allocated Bands	CFR 47 § 15.225(c)		P(Set. NPC02)	
3	Electric Field Radiated	CFR 47 § 15.209	B.2	P(Set. NFC01)	
3	Emissions	CFR 47 § 15.225(d)	B.3	P(Set. NFC01)	
4	Frequency Tolerance	CFR 47 § 15.225(e)	B.4	P(Set. NFC03)	
5	20dB Bandwidth	CFR 47 § 15.215(c)	B.5	P(Set. NFC03)	
6	Conducted Emissions	CFR 47 § 15.207	B.6	P(Set. NFC01)	
The measurement is carried out according to ANSI C63.10. See ANNEX B for details.					

#### **Test Conditions:**

For this report, all the test cases listed above were tested under normal Temperature, Voltage, humidity and Air Pressure except the Frequency Tolerance test case. The specific conditions of Frequency Tolerance test case are listed in section B.4.3

#### See Table 3 for terms for result verdict:

**Table 1 Terms for result verdict** 

Р	Pass, The EUT complies with the essential requirements in the standard.
NP	Not Perform, The test was not performed by CTTL
NA	Not Applicable, The test was not applicable
F	Fail, The EUT does not comply with the essential requirements in the standard

## 5.2. Statements

The test cases listed in Section 5.1 of this report for the EUT specified in Section 3 were performed by CTTL according to the reference documents in Section 4.

The EUT meets all applicable requirements of the regulations and standards in Section 4.2.





# 6. Test Facilities Utilized

NO.	NAME	TYPE	SERIES NUMBER	PRODUCER	CAL. DUE DATE	CAL. INTERVAL
1.	Spectrum Analyzer	FSL 6	100869	Rohde &	2022-10-23	1 Year
1.	Spectrum Analyzei	FSLO	100009	schwarz	2022-10-23	i ieai
2.	Spectrum Analyzer	FSW67	104051	R&S	2023-01-02	1 Year
3.	Climatic chamber	SH242	93008658	ESPEC	2023-02-21	2 Year
4.	Test Receiver	ESU26	100235	R&S	2023-03-08	1 Year
5.	H-field Antenna	HFH2-Z2	829324/007	R&S	2022-12-23	1 Year
6.	EMI Antenna	VULB9163	01223	Schwarzbeck	2023-07-25	1 Year
7.	Test Receiver	ESCI	100344	R&S	2023-02-21	1 Year
8.	LISN	ENV216	101200	R&S	2023-06-29	1 Year





# 7. Measurement Uncertainty

Item	Uncertainty
Frequency Tolerance	U =73 Hz, k=2
20dB Bandwidth	<i>U</i> =74 Hz, k=2
Radiated Emissions(9kHz-30MHz)	<i>U</i> =4.92 dB, k=2
Radiated Emissions (30MHz-1GHz)	<i>U</i> =5.15 dB, k=2
Radiated Emissions (>1GHz)	<i>U</i> =5.54 dB, k=2
Conducted emission	<i>U</i> = 3.08 dB, k=2





# **ANNEX A: EUT parameters**

/





## **ANNEX B: Detailed Test Results**

#### **B.1. Electric Field Strength of Fundamental and Outside the Allocated bands**

#### **B.1.1. Reference**

See CFR 47 Part 15 § 15.209 See CFR 47 Part 15 § 15.225 See Clause 4, Clause 5 of ANSI C63.10-2013 generally.

#### **B.1.2. Measurement Methods**

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

**Table B-1:** Measurement bandwidth

Frequency of Emission (MHz)	RBW/VBW
12.56-14.56	10/30 kHz

The E-field measured at 3m is calculated as:

E-field  $(dB\mu V/m) = Rx (dB\mu V) + Cable Loss (dB) + AF@3m (dB/m)$ 

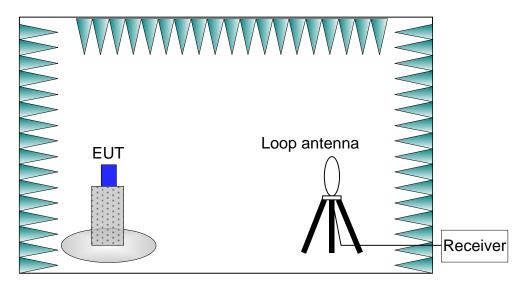


Figure B-1: Measurement Setup





## **B.1.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15  $\sim$  25  $^{\circ}$ C.

#### B.1.4. Limits

**Table B-2:** Limits

Frequency Range (MHz)	E-field Strength Limit @ 30 m (μV/m)	E-field Strength Limit @ 3 m (dBµV/m)
13.560 ± 0.007	+15,848	124
13.410 to 13.553	+334	90
13.567 to 13.710	±334	90
13.110 to 13.410	+106	01
13.710 to 14.010	Ŧ 100	81

Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula:

Extrapolat ion(dB) =  $40\log_{10}$  (Measuremen t Distance/Specification Distance)

## **B.1.5. Measurement Results**

Measurement results of normal conditions see Figure B-2 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC02, PASS.

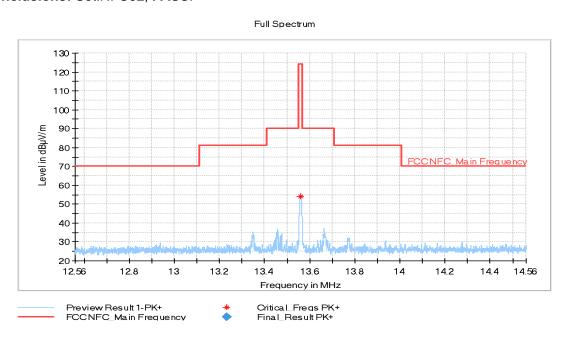


Figure B-2: Measurement results for Electric Field Strength of Fundamental and Outside the Allocated bands





## Critical\_Freqs

Frequency(MHz)	MaxPeak(dBμV/m)	Limit(dBµV/m)	Margin(dB)	Pol	Azimuth(deg)	
13.559250	53.00	124.00	71.00	V	2.0	

### **B.2. Electric Field Radiated Emissions (< 30MHz)**

#### **B.2.1. Reference**

See CFR 47 Part 15 § 15.209

See Clause 6.4 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.2.2. Measurement Methods**

The transmitter carrier output levels (E-Field) from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 3m from the receiving antenna. The center of the receiving loop antenna is 1.0 meter above the ground. The E-field is measured with a shielded loop antenna connected to a measurement receiver. Detected E-field was maximized by rotating the EUT through 360° and adjusting the receiving antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Frequency of Emission (MHz)	RBW/VBW
0.009-0.15	100/300 Hz
0.15-30	10/30 kHz

The E-field measured at 3m is calculated as:

E-field  $(dB\mu V/m) = Rx (dB\mu V) + Cable Loss (dB) + AF@3m (dB/m)$ 

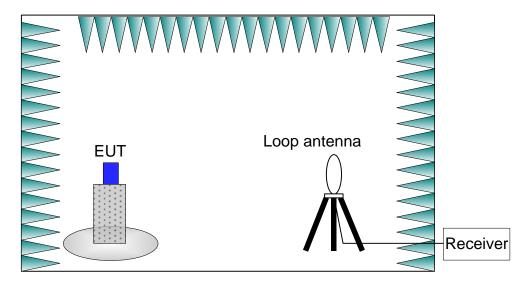


Figure B-3: Measurement Setup





#### **B.2.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is in the range of 15  $\sim$  25  $^{\circ}$ C.

#### B.2.4. Limits

Frequency Range (MHz)	E-field Strength Limit @ 30m (mV/m)	E-field Strength Limit @ 3m (dBµV/m)
0.009-0.490	2400/F(kHz)	129-94
0.490-1.705	24000/F(kHz)	74-63
1.705-30	30	70

Note: Where the limits have been defined at one distance, and a signal level measured at another, the limits have been extrapolated using the following formula:

Extrapolat ion(dB) =  $40\log_{10}$  (Measuremen t Distance/Specification Distance)

#### **B.2.5. Measurement Results**

Measurement results of normal conditions see Figure B-4 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.

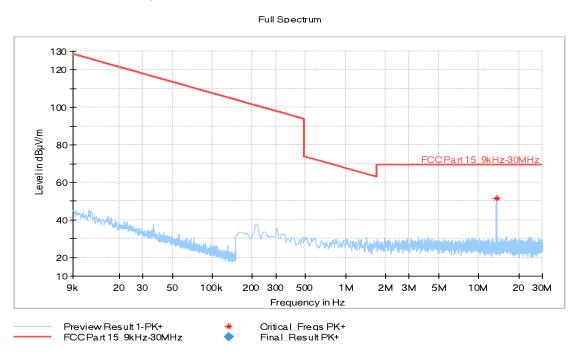


Figure B-4: Measurement results for Electric Field Radiated Emissions (< 30MHz)





## B.3. Electric Field Radiated Emissions (≥30MHz)

#### **B.3.1. Reference**

See CFR 47 Part 15 § 15.209

See Clause 6.5 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.3.2. Measurement Methods**

The electric field radiated emissions from the EUT are measured in a semi-anechoic chamber. The EUT is placed on a non-conductive stand of 80cm high, and at a measurement distance of 10m from the receiving antenna. The receiving antennas connected to a measurement receiver. In order to search for maximum field strength emitted from the EUT, the receiving antenna can be moved between the height of 1.0 m to 4.0 m. Detected E-field was maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna positions for both vertical and horizontal antenna polarizations. The maximization processes were repeated with the EUT positioned respectively in its three orthogonal axes. The measurements were performed with the peak detector and if required, the quasi-peak detector.

The measurement bandwidth is:

Frequency of Emission (MHz)	RBW/VBW
30-1000	120kHz

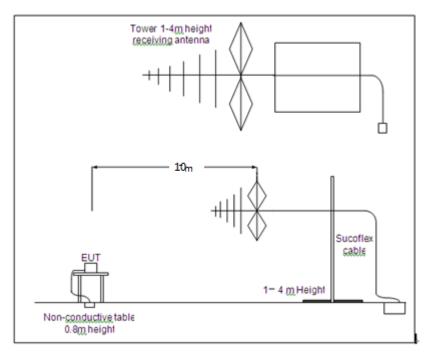


Figure B-5: Measurement Setup

#### **B.3.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT had been connected to a travel adapter.

During the measurements, the ambient temperature of the electromagnetic anechoic chamber is





in the range of 15 ~ 25  $^{\circ}$ C.

#### B.3.4. Limits

Eroguenev	E-field Strength Limit	E-field Strength Limit	E-field Strength Limit
Frequency Range (MHz)	@ 3m	@ 3m	@ 10m
Range (WITZ)	(mV/m)	(dBµV/m)	(dBµV/m)
30-88	100	40	30
88-216	150	43.5	33.5
216-960	200	46	36
960-1000	500	54	44

#### **B.3.5. Measurement Results**

Measurement results of normal conditions see Figure B-6 for different set-ups of EUT. The results displayed take into account applicable antenna factors and cable losses.

Conclusions: Set.NFC01, PASS.

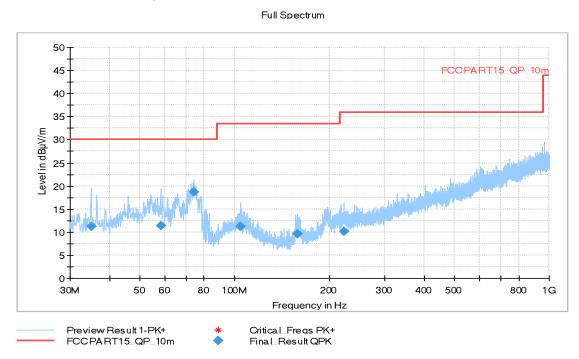


Figure B-6: Measurement results for Electric Field Radiated Emissions (≥30MHz) Final\_Result

Frequency	QuasiPeak	Limit	Margin	Height	Pol	Azimuth
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	(cm)		(deg)
34.947000	11.13	30.00	18.87	108.0	V	204.0
58.227000	11.40	30.00	18.60	183.0	V	315.0
74.135000	18.69	30.00	11.31	175.0	V	45.0
104.690000	11.24	33.52	22.28	100.0	V	45.0
158.040000	9.55	33.52	23.97	108.0	V	46.0
223.127000	10.16	36.02	25.86	100.0	V	46.0





## **B.4. Frequency Tolerance**

#### B.4.1. Reference

See CFR 47 Part 15 § 15.225(e)

See Clause 6.8 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.4.2. Measurement Methods**

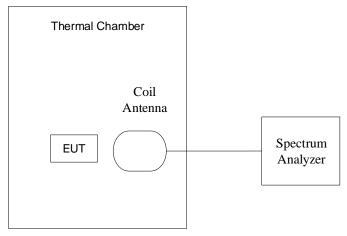


Figure B-7: Measurement Setup

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The center frequency was measured with 30Hz RBW and 1kHz span.

During the test, the EUT was placed in a thermal chamber until thermal balance and lasting appropriate time.

#### **B.4.3. EUT Operating Mode and Test Conditions**

The measurement of EUT was carried out under the transmit state of without modulation(See 3.4). EUT had not been connected to a travel adapter. The frequency stability was measured with the different voltage and temperature combinations:

- a) The nominal voltage 3.85V(See 3.1)was used and the temperature was varied from -20 $^{\circ}$ C to +50 $^{\circ}$ C in 10 $^{\circ}$ C increments using an environmental chamber.
- b) The 20 °C was used and the voltages were 3.5V, 3.85V and 4.4V (The extreme low voltage ,the normal voltage and the normal voltage defined in section 3.1).

The details were as following:

**Table B-3:** Combinations of Voltage and Temperature

Test items	Voltage	Temperature
		-20℃
E (122		-10℃
Frequency stability	3.85V	0℃
with respect to ambient temperature		10℃
		20℃
		30℃





		40℃
		50℃
Frequency stability	3.5 V	
when varying supply	3.85V	20℃
voltage	4.4V	

## **B.4.4. Test Layouts**

See B.4.2.

## B.4.5. Limits

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency.

#### **B.4.6. Measurement Results**

Measurement results see Table B-4 for different test conditions.

Conclusions: Set.NFC03, PASS.

**Table B-4:** Measurement results for Frequency Tolerance

	Tuble B 1. Freusurement results for frequency fortunee					
Temperature	Voltage	Frequency (MHz)				
remperature	Voltage	Startup	2 Min Later	5 Min Later	10 Min Later	
<b>-20</b> ℃	3.85V	13.560020000	13.560020000	13.560028000	13.560040000	
-10℃	3.85V	13.560040000	13.560060000	13.560080000	13.560012000	
0℃	3.85V	13.560040000	13.560040000	13.560020000	13.560020000	
10℃	3.85V	13.560020000	13.560040000	13.560060000	13.560060000	
20℃	3.85V	13.560060000	13.560020000	13.559980000	13.559980000	
30℃	3.85V	13.559960000	13.559980000	13.559980000	13.559980000	
40℃	3.85V	13.559960000	13.559960000	13.559940000	13.559940000	
50℃	3.85V	13.559920000	13.559940000	13.559940000	13.559980000	
20℃	3.5V	13.559980000	13.559980000	13.559980000	13.559980000	
20℃	4.4V	13.560020000	13.559980000	13.559980000	13.559980000	

Tomporatura	Voltago	Frequency Error (%)			
Temperature	Voltage	Startup	2 Min Later	5 Min Later	10 Min Later
<b>-20</b> ℃	3.85V	0.000	0.000	0.000	0.000
-10°C	3.85V	0.000	0.000	0.001	0.000
0℃	3.85V	0.000	0.000	0.000	0.000
10℃	3.85V	0.000	0.000	0.000	0.000
20℃	3.85V	0.000	0.000	0.000	0.000
30℃	3.85V	0.000	0.000	0.000	0.000
40℃	3.85V	0.000	0.000	0.000	0.000
50℃	3.85V	-0.001	0.000	0.000	0.000
20℃	3.5V	0.000	0.000	0.000	0.000
20℃	4.4V	0.000	0.000	0.000	0.000





#### **B.4.7. Measurement Uncertainty**

Measurement uncertainty: U = 73 Hz, k=2

#### B.5. 20dB Bandwidth

#### **B.5.1. Reference**

See CFR 47 Part 15 § 15.215(c)
See Clause 6.9 of ANSI C63.10-2013 specifically.
See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.5.2. Measurement Methods**

The transmitter output signal was picked up by coil antenna connected to the spectrum analyzer. The bandwidth of the center frequency was measured with 150Hz RBW, 470Hz VBW and 10kHz span.

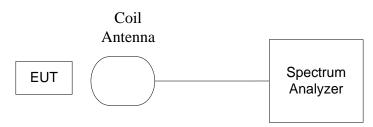


Figure B-8: Measurement Setup

### **B.5.3. EUT Operating Mode and Test Conditions**

The measurement of EUT was carried out under the transmit state of NFC (See 3.4). EUT had not been connected to a travel adapter.

During the measurements, the ambient temperature was in the range of 15 ~ 25  $\,^{\circ}$ C.

#### **B.5.4. Test Layouts**

See B.5.2.

#### B.5.5. Limits

The 20dB bandwidth shall be less than 80% of the permitted frequency band. For 13.56 MHz NFC, the permitted frequency band is 14kHz, so the limit is 11.2 kHz.

#### **B.5.6. Measurement Results**

Measurement results see Figure B-9.

Conclusions: Set.NFC03, PASS.



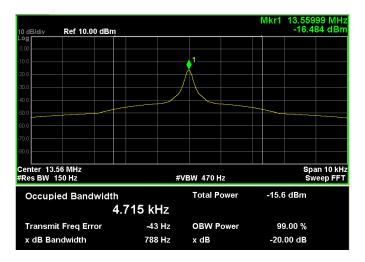


Figure B-9: Measurement results for 20dB Bandwidth

## **B.5.7. Measurement Uncertainty**

Measurement uncertainty: *U* =74 Hz, k=2

## **B.6. Conducted emission**

#### **B.6.1. Reference**

See CFR 47 Part 15 § 15.207

See Clause 6.2 of ANSI C63.10-2013 specifically.

See Clause 4 and Clause 5 of ANSI C63.10-2013 generally.

#### **B.6.2. Measurement Methods**

The conducted emissions from the AC port of the EUT are measured in a shielding room. The EUT is connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection was performed. The measurements were performed with a quasi-peak detector and if required, an average detector.

The conducted emission measurements were made with the following detector of the test receiver: Quasi-Peak / Average Detector.

The measurement bandwidth is:

**Table B-5:** Measurement Bandwidth

Frequency of Emission (MHz)	RBW/VBW
0.15-30	9kHz



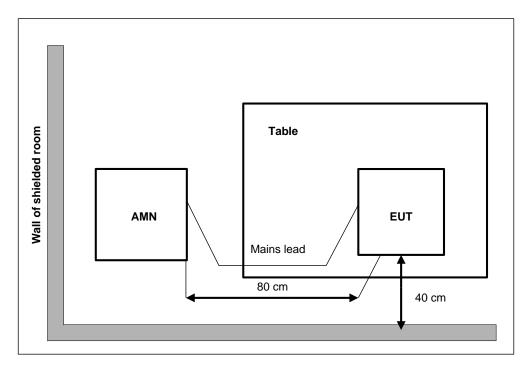


Figure B-10: Measurement Setup

## **B.6.3. EUT Operating Mode and Test Conditions**

The measurement of EUT is carried out under the transmit state of NFC(See 3.4).

The EUT is powered by a travel adapter.

During the measurements, the ambient temperature is in the range of 15 ~ 25  $\,^\circ\text{C}_{\,\cdot}$  .

#### B.6.4. Limits

Frequency range (MHz)	Quasi-peak Limit (dBμV)	Average Limit (dBμV)
0.15 to 0.5	66 to 56	56 to 46
0.5 to 5	56	46
5 to 30	60	50

#### **B.6.5. Measurement Results**

Measurement results see Figure B-11.

Conclusions: Set.NFC01, PASS.



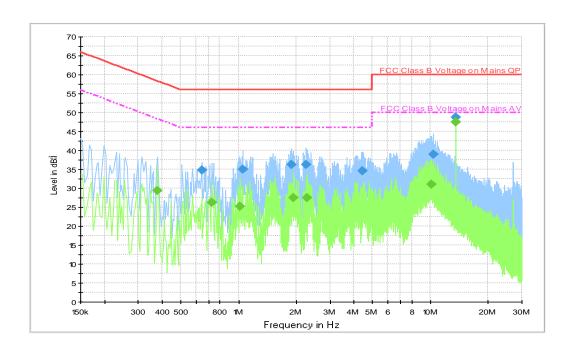


Figure B-11: Measurement results for Conducted Emission

#### **Final Result 1**

Frequency	QuasiPeak	Line	Corr.	Margin	Limit
(MHz)	(dBuV)		(dB)	(dB)	(dBuV)
0.642000	34.8	L1	19.7	21.2	56.0
1.054000	35.1	L1	19.7	20.9	56.0
1.898000	36.2	L1	19.6	19.8	56.0
2.254000	36.3	L1	19.6	19.7	56.0
4.442000	34.6	L1	19.6	21.4	56.0
10.314000	38.9	L1	19.7	21.1	60.0

## Final Result 2

Frequency (MHz)	Average (dBuV)	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)
0.378000	29.4	L1	19.7	18.9	48.3
0.726000	26.3	L1	19.7	19.7	46.0
1.022000	25.2	L1	19.7	20.8	46.0
1.930000	27.5	L1	19.6	18.5	46.0
2.286000	27.4	L1	19.6	18.6	46.0
10.090000	31.1	L1	19.7	18.9	50.0





# **ANNEX C: Persons involved in this testing**

Test Item	Tester
20dB Bandwidth	Miao Qinghua
Frequency Tolerance	Miao Qinghua
Electric Field Strength of Fundamental and Outside	Li Pengfei
the Allocated bands	
Electric Field Radiated Emissions (< 30MHz)	Li Pengfei
Electric Field Radiated Emissions (≥30MHz)	Ding Zai
Conducted Emissions	Yan Hanchen



## **ANNEX D: Accreditation Certificate**

United States Department of Commerce National Institute of Standards and Technology



## Certificate of Accreditation to ISO/IEC 17025:2017

NVLAP LAB CODE: 600118-0

## Telecommunication Technology Labs, CAICT

Beijing China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

#### Electromagnetic Compatibility & Telecommunications

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2022-10-01 through 2023-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program

\*\*\*END OF REPORT\*\*\*